Review of Performance: VEE 222 Discrete Devices II Submitted by: Cirilo Recana

## Institutional Student Learning Outcomes (ISLO's)

- 1. Effective oral communication
- 2. Effective written communication
- 3. Critical thinking
- 4. Problem solving
- 5. Intercultural knowledge and competence
- 6. Information literacy
- 7. Foundations and skills for life-long learning
- 8. Quantitative reasoning

## Program Learning Outcomes (PLO's)

- 1. Practice safety and occupational health procedures in the workplace.
- 2. Use electricity hand and power tools competently.
- 3. Test electrical equipment.
- 4. Interpret schematic wiring diagrams and waveforms.
- 5. Determine the amount of load per circuit.
- 6. Install residential wiring circuits according to given specification and plan.
- 7. Identify and interpret basic solid state (electronics) symbols and circuits schematics commonly found in the electrical industry.
- 8. Analyze circuit operation on basic motors.
- 9. Perform basic troubleshooting on basic motors.
- 10. Install and perform basic maintenance on air-conditioning units.
- 11. Interpret and install circuits according to rules and regulations of the National Electrical Code book.
- 12. Install and analyze basic motor control circuits.

SLO#	PLO	I, D, M	ISLO	Reflection/Comment		
SLO#1 Describe the purpose and operation of Unijunction Transistor (UJT) and Silicon Controlled Rectifier (SCR).	4, 7	I (introduced level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:		
				No. of students	Score	Comment
				2	69 or lower	Failed
				13	70 or better	Passed

				13% failed, 87% passed <b>Observation:</b> Due to the pace of the class, most parts of hands-on experimentation were not delivered because of needed additional time spent on theoretical concept and circuit calculation.		
SLO#2 Describe UJT oscillator circuit operation.	4, 7	I,D (introduced and demonstrate level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:		
				No. of students	Score	Comment
				3	69 or lower	Failed
				12	70 or better	Passed
				20% failed, 80% pa <b>Observation:</b> Due to hands-on experiment needed equipment s for UJT experiment	ssed o the pace of the cla ntation were not del uch as analog meter	ess, most parts of ivered because of r and NIDA card
SLO#3 Describe SCR trigger circuit operation.	4, 7	I,D (introduced and demonstrate level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:		
				No. of students	Score	Comment
				1	69 or lower	Failed
				14	70 or better	Passed
				7% failed, 93% pass	sed	
				<b>Observation:</b> Due to hands-on experimen needed additional to circuit calculation.	o the pace of the cla ntation were not del me spent on theoret	ess, most parts of ivered because of fical concept and

				A good analog multi-meter and additional oscilloscope must be purchase so students can grasp the use of this instrument in their experimentation activities.		
SLO#4 Describe SCR power control operation.	4, 7	D (demonstrate level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:		
				No. of students	Score	Comment
				1	69 or lower	Failed
				14	70 or better	Passed
				7% failed, 93% pass	sed	
				<b>Observation:</b> Due to hands-on experimen needed additional N not enough for the o Additional NIDA ca meter and test conso	o the size of the clas ntation were not deli IIDA cards and testi class. and for SCR, analog ple are needed.	s, most parts of vered because of ng instruments are meter, digital
SLO#5 Identify the relationship among Triac, SCRs , Diac and four-layered devices.	4, 7	I,D (introduced and demonstrate level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:		
				No. of students	Score	Comment
				3	69 or lower	Failed
				12	70 or better	Passed
				20% failed, 80% passed <b>Observation:</b> Due to the pace of the class, most parts of hands-on experimentation were not delivered because of unavailability NIDA card for this experiment. We just emphasize more on the theoretical part of each component.		

SLO#6 Describe the construction, operation and application of Programmable Unijuction Transistor (PUT).	4, 7	I,D (introduced and demonstrate level)	3	SLO was assessed by written test questions using the assessment criteria as stated in the course outline. Result of assessment is shown below:				
				No. of students	Score	Comment		
				2	69 or lower	Failed		
				13	70 or better	Passed		
				13% failed, 87% passed				
				hands-on experiment needed additional the circuit calculation.	noservation: Due to the pace of the class, most parts of nands-on experimentation were not delivered because of needed additional time spent on theoretical concept and rircuit calculation.			

Additional observations: In reference with the data presented above, high percentage showed students are highly interested in hands-on experimentation or class activities.

STUDENTS FINAL GRADES BREAKDOWN:A = 1B = 8C = 6D = [none]F = [none]

**Recommendations:** Laboratory equipments (NIDA cards) for discrete devices II must be enough for at least 3 to 5 sets to be able for the students to perform their required experiment. Additional good quality analog multi-meter and oscilloscope must also be purchase so that more hands on experimentation can be done.

A plan to modify and combine discrete devices I & II course into one course for electrical students use so that it focus only on discrete devices that are needed in the electrical controls.

Signature:

Cirilo B. Recana Electrical Instructor Date Submitted: December 2013